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- Bidirectional Transceivers
- Meet or Exceed the Requirements of ANSI Standards EIA/TIA-422-B and RS-485 and ITU Recommendations V.11 and X.27
- Designed for Multipoint Transmission on Long Bus Lines in Noisy Environments
- 3-State Driver and Receiver Outputs
- Individual Driver and Receiver Enables
- Wide Positive and Negative Input/Output Bus Voltage Ranges
- Driver Output Capability . . . ±60 mA Max
- Thermal Shutdown Protection
- Driver Positive and Negative Current Limiting
- Receiver Input Impedance . . . 12 kΩ Min
- Receiver Input Sensitivity . . . ±200 mV
- Receiver Input Hysteresis . . . 50 mV Typ
- Operate From Single 5-V Supply

description

The SN65176B and SN75176B differential bus transceivers are monolithic integrated circuits designed for bidirectional data communication on multipoint bus transmission lines. They are designed for balanced transmission lines and meet ANSI Standards EIA/TIA-422-B and RS-485 and ITU Recommendations V.11 and X.27.

The SN65176B and SN75176B combine a 3-state differential line driver and a differential input line receiver, both of which operate from a single 5-V power supply. The driver and receiver have active-high and active-low enables, respectively, that can be externally connected together to function as a direction control. The driver differential outputs and the receiver differential inputs are connected internally to form differential input/output (I/O) bus ports that are designed to offer minimum loading to the bus whenever the driver is disabled or $V_{CC} = 0$. These ports feature wide positive and negative common-mode voltage ranges making the device suitable for party-line applications.

The driver is designed for up to 60 mA of sink or source current. The driver features positive- and negative-current limiting and thermal shutdown for protection from line-fault conditions. Thermal shutdown is designed to occur at a junction temperature of approximately 150°C. The receiver features a minimum input impedance of 12 k Ω , an input sensitivity of ±200 mV, and a typical input hysteresis of 50 mV.

The SN65176B and SN75176B can be used in transmission line applications employing the SN75172 and SN75174 quadruple differential line drivers and SN75173 and SN75175 quadruple differential line receivers.

The SN65176B is characterized for operation from -40° C to 105° C and the SN75176B is characterized for operation from 0° C to 70° C.



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PRODUCTION DATA information is current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.



D OR P PACKAGE (TOP VIEW)						
RE DE DE	1 2 3 4	U	8 7 6 5] V _{CC}] B] A] GND		

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Function Tables

n	RI	v	D	
	NI	v	n	

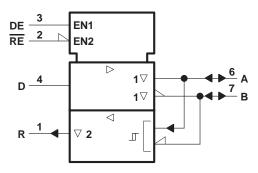
INPUT	ENABLE	Ουτι	PUTS
D	DE	Α	В
Н	Н	Н	L
L	Н	L	н
Х	L	Z	Z



DIFFERENTIAL INPUTS A – B	ENABLE RE	OUTPUT R					
$V_{ID} \ge 0.2 V$	L	Н					
$-0.2 \text{ V} < \text{V}_{\text{ID}} < 0.2 \text{ V}$	L	?					
$V_{ID} \le -0.2 V$	L	L					
Х	н	Z					
Open	L	н					

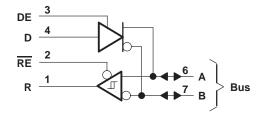
H = high level, L = low level, ? = indeterminate, X = irrelevant, Z = high impedance (off)

logic symbol[†]



[†] This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

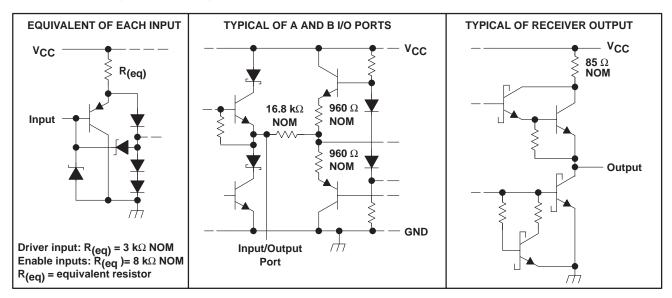
logic diagram (positive logic)





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schematics of inputs and outputs



absolute maximum ratings over operating free-air temperature range (unless otherwise noted)[†]

Supply voltage, V _{CC} (see Note 1)	
Voltage range at any bus terminal	– 10 V to 15 V
Enable input voltage, V _I	5.5 V
Continuous total power dissipation	
Operating free-air temperature range, T _A : SN65176B	–40°C to 105°C
SN75176B	0°C to 70°C
Storage temperature range, T _{stg} Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds	– 65°C to 150°C
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds	260°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: All voltage values, except differential input/output bus voltage, are with respect to network ground terminal.

DISSIPATION RATING TABLE							
$\begin{array}{c} \textbf{PACKAGE} & \textbf{T}_{\textbf{A}} \leq 25^{\circ}\textbf{C} \\ \textbf{POWER RATING} \end{array}$		DERATING FACTOR ABOVE T _A = 25°C	T _A = 70°C POWER RATING	T _A = 105°C POWER RATING			
D	725 mW	5.8 mW/°C	464 mW	261 mW			
Р	1100 mW	8.8 mW/°C	704 mW	396 mW			

DISSIPATION RATING TABLE



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recommended operating conditions

			MIN	TYP	MAX	UNIT
Supply voltage, V _{CC}			4.75	5	5.25	V
Voltage at any bus terminal (separately or common mode), V_I or V_{IC}					12	V
				-7	v	
High-level input voltage, VIH	D, DE, and RE		2			V
Low-level input voltage, VIL	D, DE, and RE				0.8	V
Differential input voltage, V_{ID} (see No	ote 2)				±12	V
	Driver				-60	mA
High-level output current, IOH				-400	μΑ	
	Driver				60	mA
	Receiver			8	ША	
Operating free air temperature Te	SN65176B		-40		105	°C
Operating free-air temperature, T_A	SN75176B		0		70	C

NOTE 2: Differential-input/output bus voltage is measured at the noninverting terminal A with respect to the inverting terminal B.



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DRIVER SECTION

electrical characteristics over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

	PARAMETER	TEST CONI	DITIONS [†]	MIN	TYP‡	MAX	UNIT	
VIK	Input clamp voltage	lı = –18 mA				-1.5	V	
VO	Output voltage	IO = 0		0		6	V	
VOD1	Differential output voltage	IO = 0		1.5	3.6	6	V	
VOD2	Differential output voltage	R _L = 100 Ω,	See Figure 1	1/2 V _{OD1} or 2¶			V	
		R _L = 54 Ω,	See Figure 1	1.5	2.5	5	V	
V _{OD3}	Differential output voltage	See Note 4		1.5		5	V	
	Change in magnitude of differential output voltage§					±0.2	V	
Voc	Common-mode output voltage	$R_L = 54 \Omega$ or 100 Ω, See Figure 1				+3 -1	V	
∆ Voc	Change in magnitude of common-mode output voltage§					±0.2	V	
10	Output current	Output disabled,	V _O = 12 V			1	mA	
10	Output current	See Note 3	$V_{O} = -7 V$			-0.8	ШA	
Iн	High-level input current	VI = 2.4 V				20	μΑ	
۱L	Low-level input current	VI = 0.4 V				-400	μA	
		V _O = -7 V				-250		
		$V_{O} = 0$				150	1	
los	Short-circuit output current	$V_{O} = V_{CC}$				250	mA	
		V _O = 12 V				250		
1	Supply surrent (total postogo)	No load	Outputs enabled		42	70	~ ^	
ICC	Supply current (total package)	100 1080	Outputs disabled		26	35	mA	

[†] The power-off measurement in ANSI Standard EIA/TIA-422-B applies to disabled outputs only and is not applied to combined inputs and outputs. [‡] All typical values are at $V_{CC} = 5 V$ and $T_A = 25^{\circ}$ C.

§ ∆|V_{OD}| and ∆|V_{OC}| are the changes in magnitude of V_{OD} and V_{OC}, respectively, that occur when the input is changed from a high level to a low level.

 \P The minimum V_{OD2} with a 100- Ω load is either 1/2 V_{OD1} or 2 V, whichever is greater.

NOTES: 3. See ANSI Standard RS-485 Figure 3.5, Test Termination Measurement 2.

4. This applies for both power on and off; refer to ANSI Standard RS-485 for exact conditions. The EIA/TIA-422-B limit does not apply for a combined driver and receiver terminal.

switching characteristics, V_{CC} = 5 V, R_L = 110 k Ω , T_A = 25°C (unless otherwise noted)

PARAMETER		TEST C	TEST CONDITIONS		TYP	MAX	UNIT
td(OD)	Differential-output delay time	$R_1 = 54 \Omega_1$	See Figure 3		15	22	ns
^t t(OD)	Differential-output transition time	KL = 54 32,	See Figure 5		20	30	ns
^t PZH	Output enable time to high level	See Figure 4			85	120	ns
t _{PZL}	Output enable time to low level	See Figure 5			40	60	ns
^t PHZ	Output disable time from high level	See Figure 4			150	250	ns
^t PLZ	Output disable time from low level	See Figure 5			20	30	ns



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	SYMBOL EQUIVALENTS						
DATA-SHEET PARAMETER	EIA/TIA-422-B	RS-485					
Vo	V _{oa,} V _{ob}	V _{oa,} V _{ob}					
IVOD1	V _O	Vo					
IVOD2	V _t (R _L = 100 Ω)	V _t (R _L = 54 Ω)					
IV0D3I		V _t (Test Termination Measurement 2)					
	$ V_t - \overline{V}_t $	$ V_t - \overline{V}_t $					
Voc	V _{os}	V _{os}					
	V _{OS} – V _{OS}	V _{OS} – V _{OS}					
IOS	I _{sa} , I _{sb}						
IO	I _{xa} , I _{xb}	l _{ia} , l _{ib}					

RECEIVER SECTION

electrical characteristics over recommended ranges of common-mode input voltage, supply voltage, and operating free-air temperature (unless otherwise noted)

PARAMETER		TEST C	TEST CONDITIONS		TYP†	MAX	UNIT
V_{IT+}	Positive-going input threshold voltage	V _O = 2.7 V,	$I_{O} = -0.4 \text{ mA}$			0.2	V
V_{IT-}	Negative-going input threshold voltage	V _O = 0.5 V,	I _O = 8 mA	-0.2‡			V
V _{hys}	Input hysteresis voltage (V _{IT+} – V _{IT} _)				50		mV
VIK	Enable Input clamp voltage	lı = –18 mA				-1.5	V
VOH	High-level output voltage	V _{ID} = 200 mV, See Figure 2	I _{OH} = -400 μA,	2.7			V
V _{OL}	Low-level output voltage	$V_{ID} = -200 \text{ mV},$ See Figure 2	I _{OL} = 8 mA,			0.45	V
IOZ	High-impedance-state output current	V _O = 0.4 V to 2.4 V				±20	μΑ
1.		Other input = 0 V,	V _I = 12 V			1	4
1	Line input current	See Note 5	$V_{I} = -7 V$			-0.8	mA
IIН	High-level enable input current	VIH = 2.7 V	-			20	μΑ
١ _{IL}	Low-level enable input current	V _{IL} = 0.4 V				-100	μΑ
rj	Input resistance	V _I = 12 V		12			kΩ
los	Short-circuit output current			-15		-85	mA
1	Supply surrent (total neckage)	Natari	Outputs enabled	42		55	
ICC	Supply current (total package)	No load	Outputs disabled		26	35	mA

[†] All typical values are at V_{CC} = 5 V, T_A = 25°C. [‡] The algebraic convention, in which the less positive (more negative) limit is designated minimum, is used in this data sheet for common-mode input voltage and threshold voltage levels only.

NOTE 5: This applies for both power on and power off. Refer to EIA Standard RS-485 for exact conditions.



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	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
t _{PLH}	Propagation delay time, low- to high-level output	$V_{ID} = 0$ to 3 V, See Figure 6		21	35	ns
^t PHL	Propagation delay time, high- to low-level output			23	35	ns
^t PZH	Output enable time to high level	See Figure 7		10	20	ns
t _{PZL}	Output enable time to low level	See Figure 7		12	20	ns
^t PHZ	Output disable time from high level	See Figure 7		20	35	ns
t _{PLZ}	Output disable time from low level	See Figure 7		17	25	ns

switching characteristics, V_{CC} = 5 V, C_L = 15 pF, T_A = 25°C

PARAMETER MEASUREMENT INFORMATION

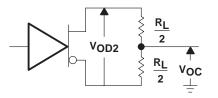
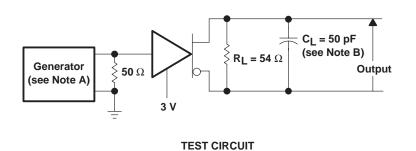


Figure 1. Driver V_{OD} and V_{OC}



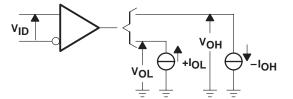
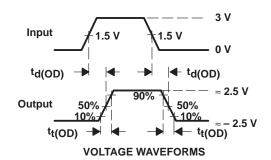


Figure 2. Receiver V_{OH} and V_{OL}

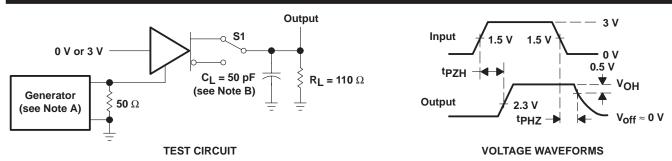


- NOTES: A. The input pulse is supplied by a generator having the following characteristics: PRR \leq 1 MHz, 50% duty cycle, t_f \leq 6 ns, t_f \leq 6 ns, Z_O = 50 Ω .
 - B. C_{L} includes probe and jig capacitance.

Figure 3. Driver Test Circuit and Voltage Waveforms

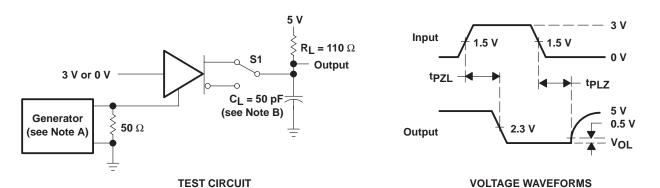


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- NOTES: A. The input pulse is supplied by a generator having the following characteristics: PRR \leq 1 MHz, 50% duty cycle, t_f \leq 6 ns, t_f \leq 6 ns, Z_Q = 50 Ω .
 - B. CL includes probe and jig capacitance.

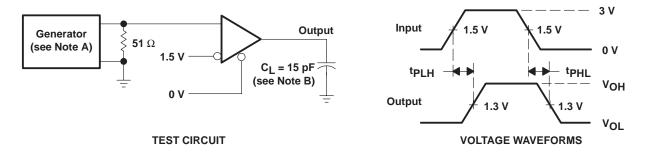
Figure 4. Driver Test Circuit and Voltage Waveforms



NOTES: A. The input pulse is supplied by a generator having the following characteristics: PRR \leq 1 MHz, 50% duty cycle, t_f \leq 6 ns, t_f \leq 6 ns, Z_O = 50 Ω .

B. C_{L} includes probe and jig capacitance.

Figure 5. Driver Test Circuit and Voltage Waveforms



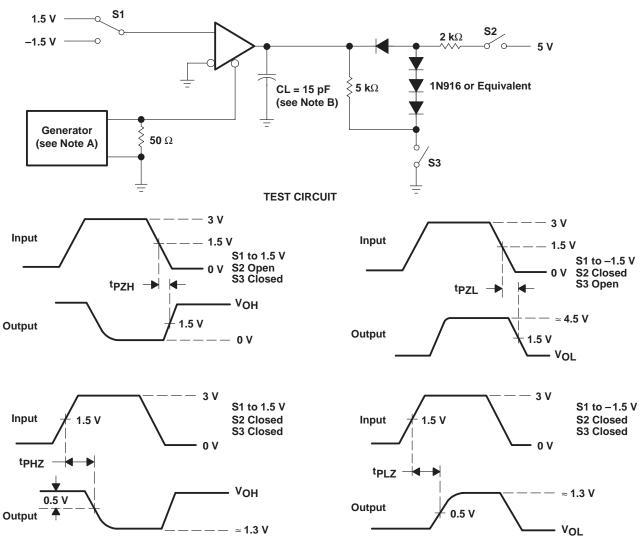
NOTES: A. The input pulse is supplied by a generator having the following characteristics: PRR \leq 1 MHz, 50% duty cycle, t_f \leq 6 ns, t_f \leq 6 ns, Z_O = 50 Ω .

B. CL includes probe and jig capacitance.

Figure 6. Receiver Test Circuit and Voltage Waveforms



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PARAMETER MEASUREMENT INFORMATION

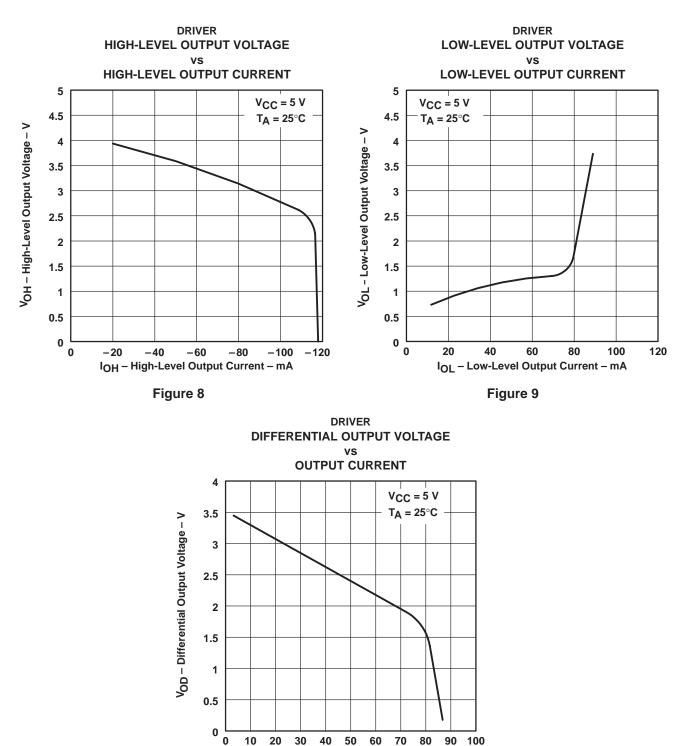
VOLTAGE WAVEFORMS

- NOTES: A. The input pulse is supplied by a generator having the following characteristics: PRR \leq 1 MHz, 50% duty cycle, t_f \leq 6 ns, t_f \leq 8 ns, t_f
 - B. C_{L} includes probe and jig capacitance.

Figure 7. Receiver Test Circuit and Voltage Waveforms



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TYPICAL CHARACTERISTICS

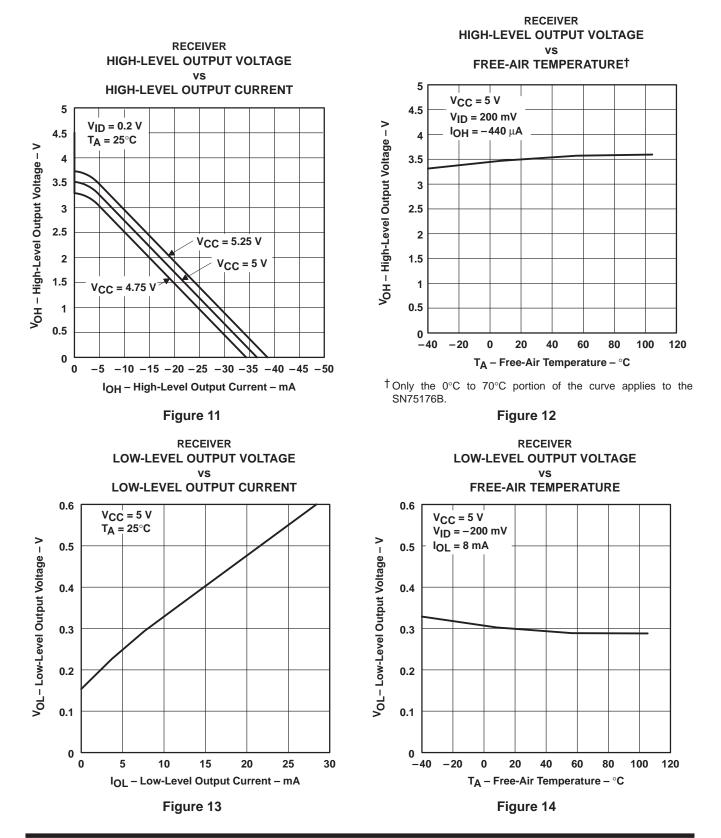
Figure 10

IO - Output Current - mA

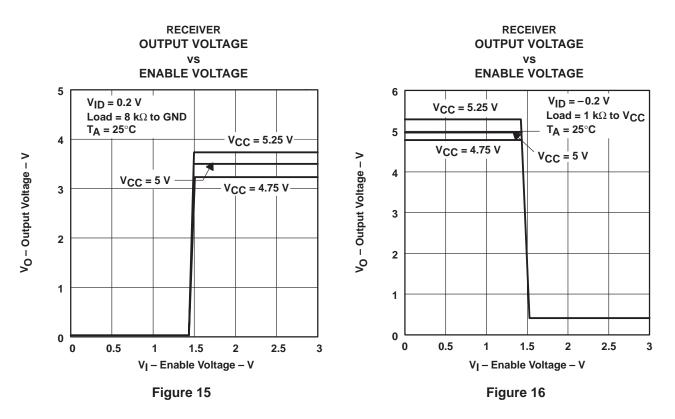


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TYPICAL CHARACTERISTICS

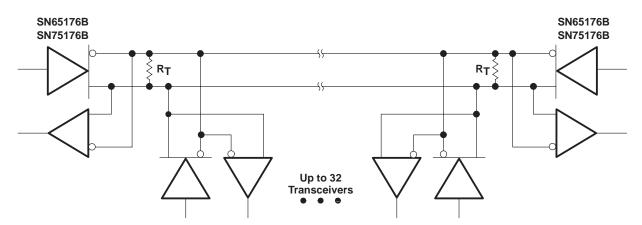


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TYPICAL CHARACTERISTICS





NOTES: A. The line should be terminated at both ends in its characteristic impedance (R_T = Z_O). Stub lengths off the main line should be kept as short as possible.

Figure 17. Typical Application Circuit



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